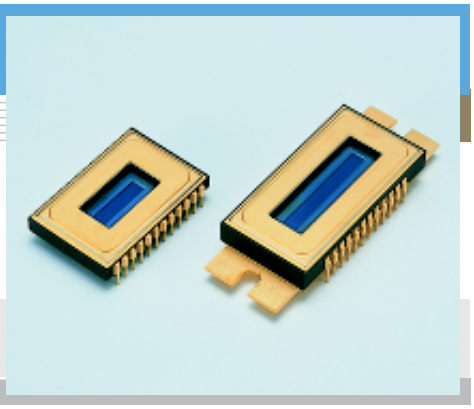
CCD area image sensor
S7033/S7034 series

Back-thinned FFT-CCD



S7033/S7034 series are families of FFT-CCD image sensors specifically designed for low-light-level detection in scientific applications. S7033/S7034 series feature large full-well capacity in horizontal CCD register. By using the binning operation, S7033/S7034 series can be used as a linear image sensor having a long height. This makes S7033/S7034 series ideally suited for use in spectrophotometry. The binning operation offers significant improvement in S/N and signal processing speed compared with conventional methods by which signals are digitally added by an external circuit.
S7033/S7034 series have an effective pixel size of 24 × 24 µm and are available in image areas ranging from 12.288 (H) × 2.928 (V) mm^2 (S7033-0907, S7034-0907S) up to a large image area of 24.576 (H) × 2.928 (V) mm^2 (S7033-1007, S7034-1007S).
Either one-stage or two-stage thermoelectric cooler is built into the package (S7034/S7035 series). At room temperature operation, the device can be cooled down to -10 ˚C by one-stage cooler and -30 ˚C by two-stage cooler respectively without using any other cooling technique. In addition since both the CCD chip and the thermoelectric cooler are hermetically sealed, no dry air is required, thus allowing easy handling.

Features

- Line, pixel binning
- Greater than 90 % quantum efficiency at peak sensitivity wavelength
- Wide spectral range
- Wide dynamic range
- MPP operation
- Built-in thermoelectric cooler

Applications

- Fluorescence spectrometer, ICP
- Industrial inspection requiring
- Semiconductor inspection
- DNA sequencer
- Low-light-level detection

■ Selection guide

Type No.	Cooling	Number of total pixels	Number of active pixels	Active area [mm (H) × mm (V)]	Suitable multichannel detector head
S7033-0907	Non-cooled	532 × 128	512 × 122	12.288 × 2.928	C7043
S7033-1007		1044 × 128	1024 × 122	24.576 × 2.928	
S7034-0907S	One-stage TE-cooled	532 × 128	512 × 122	12.288 × 2.928	C7044
S7034-1007S		1044 × 128	1024 × 122	24.576 × 2.928	

Note) Two-stage TE-cooled type (S7035 series) is also available

■ General ratings

Parameter	S7033 series	S7034 series
Pixel size	24 (H) × 24 (V) µm	
Vertical clock phase	2 phase	
Horizontal clock phase	2 phase	
Output circuit	One-stage MOSFET source follower	
Package	24 pin ceramic DIP (refer to dimensional outlines)	
Built-in cooler	-	One-stage
Window *1	Quartz glass	Sapphire

*1: Window-less is available upon request.

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■ Absolute maximum ratings (Ta=25 °C)

Parameter	Symbol	Min.	Typ.	Max.	Unit
Operating temperature	Topr	-50	-	+30	°C
Storage temperature	Tstg	-50	-	+70	°C
OD voltage	V_{OD}	-0.5	-	+25	V
RD voltage	V_{RD}	-0.5	-	+18	V
ISV voltage	V_{ISV}	-0.5	-	+18	V
ISH voltage	V_{ISH}	-0.5	-	+18	V
IGV voltage	V_{IG1V}, V_{IG2V}	-10	-	+15	V
IGH voltage	V_{IG1H}, V_{IG2H}	-10	-	+15	V
SG voltage	V_{SG}	-10	-	+15	V
OG voltage	V_{OG}	-10	-	+15	V
RG voltage	V_{RG}	-10	-	+15	V
TG voltage	V_{TG}	-10	-	+15	V
Vertical clock voltage	V_{P1V}, V_{P2V}	-10	-	+15	V
Horizontal clock voltage	V_{P1H}, V_{P2H}	-10	-	+15	V

■ Operating conditions (MPP mode, Ta=25 °C)

Parameter		Symbol	Min.	Typ.	Max.	Unit
Output transistor drain voltage		V_{OD}	18	20	22	V
Reset drain voltage		V_{RD}	11.5	12	12.5	V
Output gate voltage		V_{OG}	1	3	5	V
Substrate voltage		V_{SS}	-	0	-	V
Test point (vertical input source)		V_{ISV}	-	V_{RD}	-	V
Test point (horizontal input source)		V_{ISH}	-	V_{RD}	-	V
Test point (vertical input gate)		V_{IG1V}, V_{IG2V}	-8	0	-	V
Test point (horizontal input gate)		V_{IG1H}, V_{IG2H}	-8	0	-	V
Vertical shift register clock voltage	High	V_{P1VH}, V_{P2VH}	4	6	8	V
	Low	V_{P1VL}, V_{P2VL}	-9	-8	-7	
Horizontal shift register clock voltage	High	V_{P1HH}, V_{P2HH}	4	6	8	V
	Low	V_{P1HL}, V_{P2HL}	-9	-8	-7	
Summing gate voltage	High	V_{SGH}	4	6	8	V
	Low	V_{SGL}	-9	-8	-7	
Reset gate voltage	High	V_{RGH}	4	6	8	V
	Low	V_{RGL}	-9	-8	-7	
Transfer gate voltage	High	V_{TGH}	4	6	8	V
	Low	V_{TGL}	-9	-8	-7	

■ Electrical characteristics (Ta=25 °C)

Parameter	Symbol	Min.	Typ.	Max.	Unit
Signal output frequency	fc	-	-	1	MHz
Charge transfer efficiency *2	CTE	0.99995	0.99999	-	-
DC output level *3	Vout	12	15	18	V
Output impedance *3	Zo	-	3	-	kΩ
Power consumption *3 *4	P	-	15	-	mW

*2: Charge transfer efficiency per pixel, measured at half of the full well capacity.
*3: The values depend on the load resistance. (Typical, V_{OD}=20 V, Load resistance=22 kΩ)
*4: Power consumption of the on-chip amplifier.

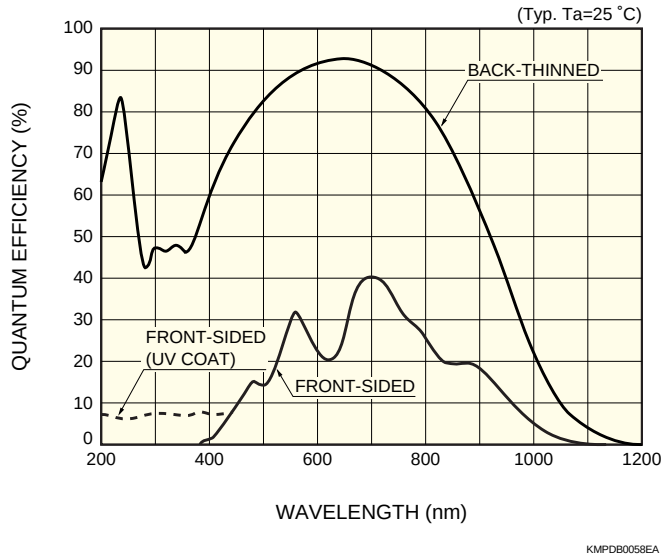
■ Electrical and optical characteristics (Ta=25 °C, unless otherwise noted)

Parameter		Symbol	Min.	Typ.	Max.	Unit
Saturation output voltage		Vsat	-	Fw × Sv	-	V
Full well capacity	Vertical	Fw	150,000	300,000	-	e^-
	Horizontal		1,350,000	2,700,000	-	
CCD node sensitivity		Sv	0.5	0.6	-	μV/e^-
Dark current *5 (MPP mode)	25 °C	DS	-	4,000	12,000	e^-/pixel/s
	0 °C		-	200	600	
Readout noise *6		Nr	-	30	-	e^- rms
Dynamic range *7	Line binning	DR	22,500	90,000	-	-
	Area scanning		2,500	10,000	-	
Photo response non-uniformity *8		PRNU	-	±3	±10	%
Spectral response range		λ	-	200 to 1100	-	nm

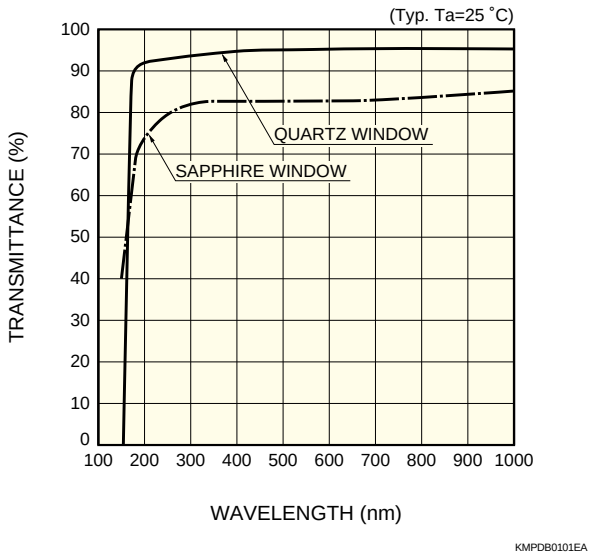
*5: Dark current nearly doubles for every 5 to 7 °C increase in temperature.
*6: Operating frequency is 150 kHz.
*7: Dynamic range (DR)=Full well/Readout noise.
*8: Measured at the half of the full well capacity output.

$$\text{Photo response non-uniformity (PRNU) [\%]} = \frac{\text{Fixed pattern noise (peak to peak)}}{\text{Signal}} \times 100$$

■ Spectral response (without window) *9



■ Spectral transmittance characteristics of window material



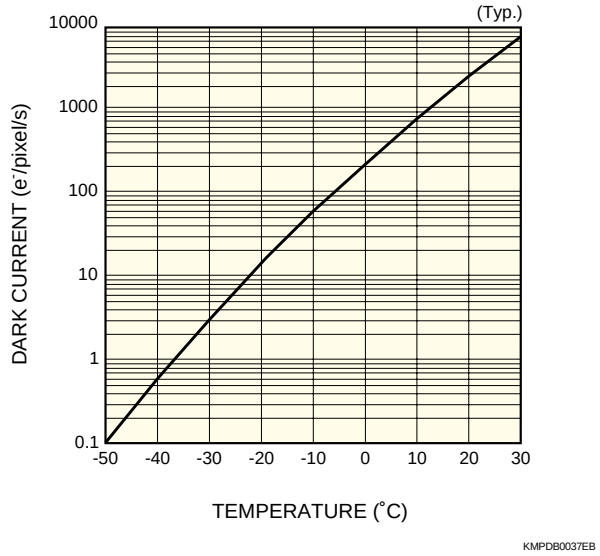
*9: Spectral response with quartz glass or sapphire are decreased by the transmittance.

● Window material

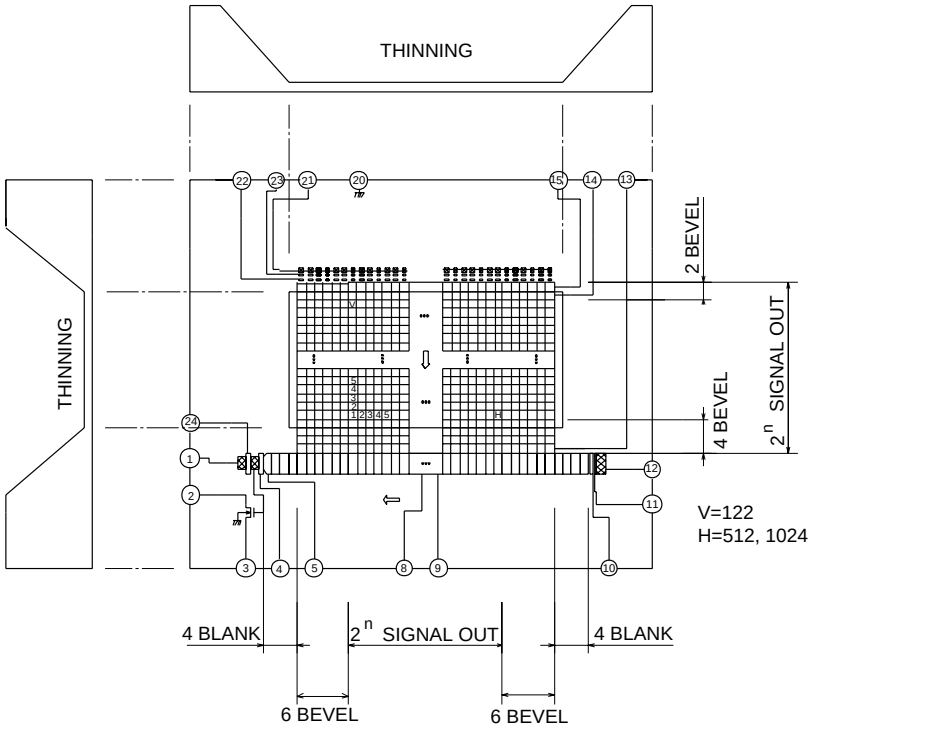
Type No.	Window material
S7033 series	Quartz glass *10 (option: window-less,)
S7034 series	Sapphire *11 (option: window-less)
S7035 series (two-stage TE-cooled type)	Sapphire *11 (option: window-less)

*10: Resin sealing
*11: Hermetic sealing

■ Dark current vs. temperature

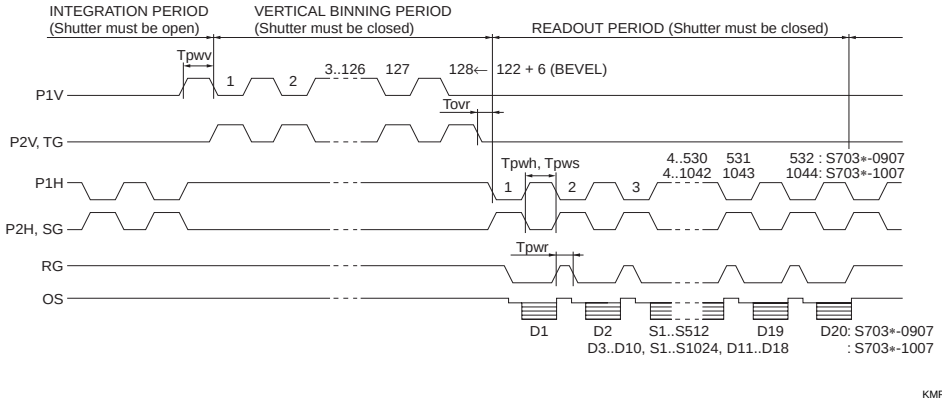


■ Device structure (Conceptual drawing of top view)



■ Timing chart

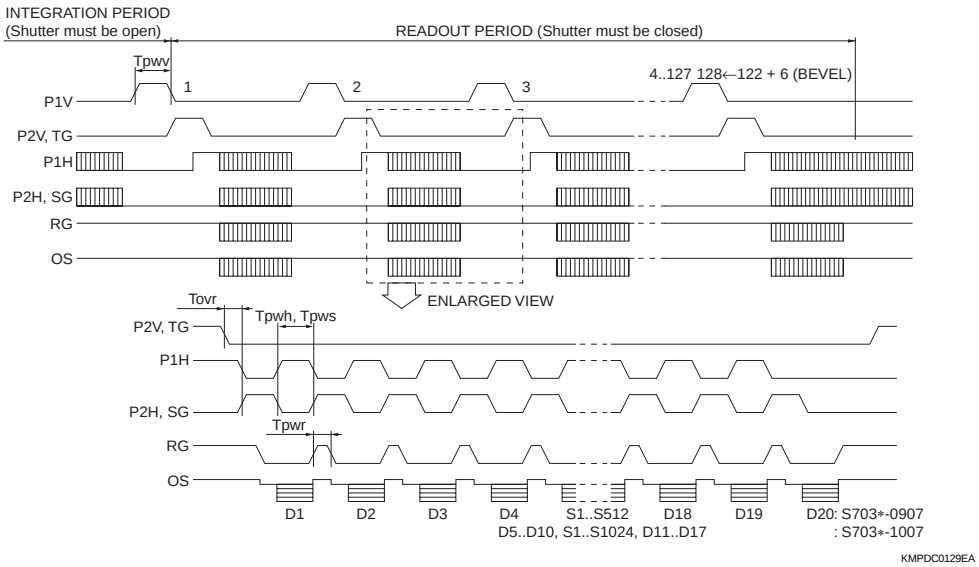
Line binning



Parameter		Symbol	Remark	Min.	Typ.	Max.	Unit
P1V, P2V, TG	Pulse width	Tpwv	*12	6 *13	-	-	µs
	Rise and fall time	Tprv, Tpfv		200	-	-	ns
P1H, P2H	Pulse width	Tpwh	*12	500	-	-	ns
	Rise and fall time	Tprh, Tpfh		10	-	-	ns
	Duty ratio	-		-	50	-	%
SG	Pulse width	Tpws	-	500	-	-	ns
	Rise and fall time	Tprs, Tpfs		10	-	-	ns
	Duty ratio	-		-	50	-	%
RG	Pulse width	Tpwr	-	100	-	-	ns
	Rise and fall time	Tprr, Tpfr		5	-	-	ns
TG – P1H	Overlap time	Tovr	-	3	-	-	µs

*12: Symmetrical pulses should be overlapped at 50 % of maximum amplitude.
*13: In case of S7033-1007, S7034-1007S

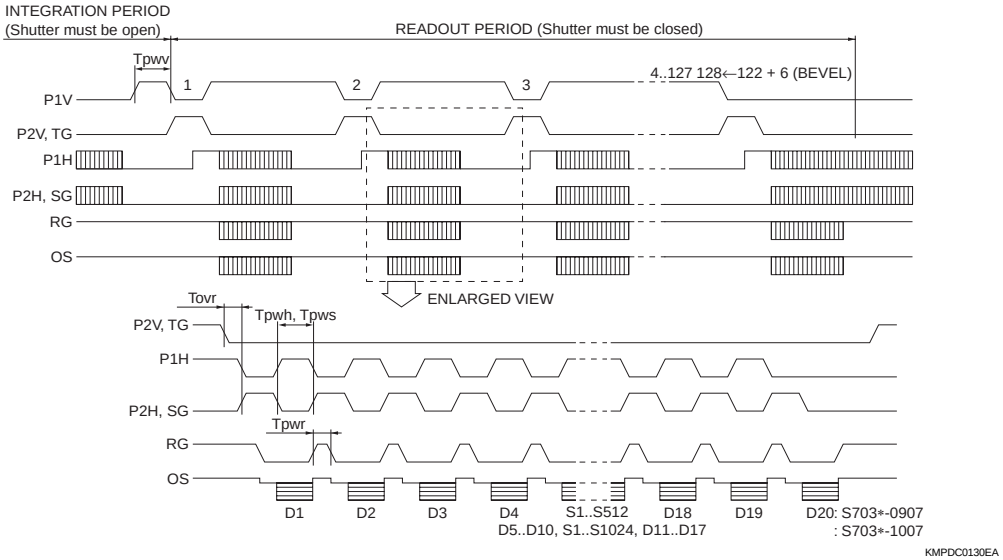
Area scanning 1: low dark current mode



Parameter		Symbol	Remark	Min.	Typ.	Max.	Unit
P1V, P2V, TG	Pulse width	Tpwv	*14	6 *15	-	-	µs
	Rise and fall time	Tprv, Tpfv		200	-	-	ns
P1H, P2H	Pulse width	Tpwh	*14	500	-	-	ns
	Rise and fall time	Tprh, pfh		10	-	-	ns
	Duty ratio	-		-	50	-	%
SG	Pulse width	Tpws	-	500	-	-	ns
	Rise and fall time	Tprs, Tpfs		10	-	-	ns
	Duty ratio	-		-	50	-	%
RG	Pulse width	Tpwr	-	100	-	-	ns
	Rise and fall time	Tprr, Tpfr		5	-	-	ns
TG – P1H	Overlap time	Tovr	-	3	-	-	µs

*14: Symmetrical pulses should be overlapped at 50 % of maximum amplitude.
*15: In case of S7033-1007, S7034-1007S

Area scanning 2: large full well mode

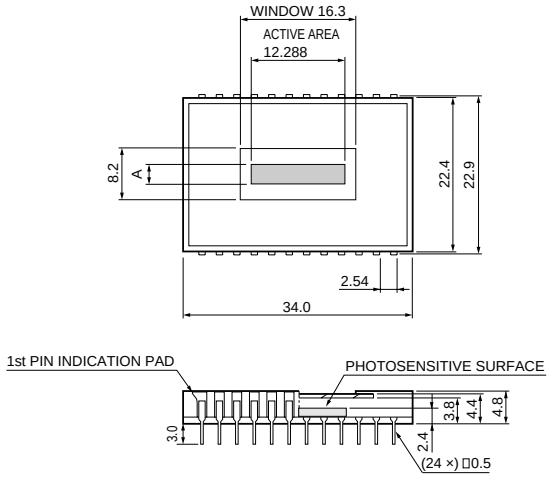


Parameter		Symbol	Remark	Min.	Typ.	Max.	Unit
P1V, P2V, TG	Pulse width	Tpwv	*16	6 *17	-	-	µs
	Rise and fall time	Tprv, Tpfv		200	-	-	ns
P1H, P2H	Pulse width	Tpwh	*16	500	-	-	ns
	Rise and fall time	Tprh, Tpfh		10	-	-	ns
	Duty ratio	-		-	50	-	%
SG	Pulse width	Tpws	-	500	-	-	ns
	Rise and fall time	Tprs, Tpfs		10	-	-	ns
	Duty ratio	-		-	50	-	%
RG	Pulse width	Tpwr	-	100	-	-	ns
	Rise and fall time	Tprr, Tpfr		5	-	-	ns
TG - P1H	Overlap time	Tovr	-	3	-	-	µs

*16: Symmetrical pulses should be overlapped at 50 % of maximum amplitude.
*17: In case of S7033-1007, S7034-1007S

■ Dimensional outlines (unit: mm)

S7033-0907



S7033-0907: A=2.928

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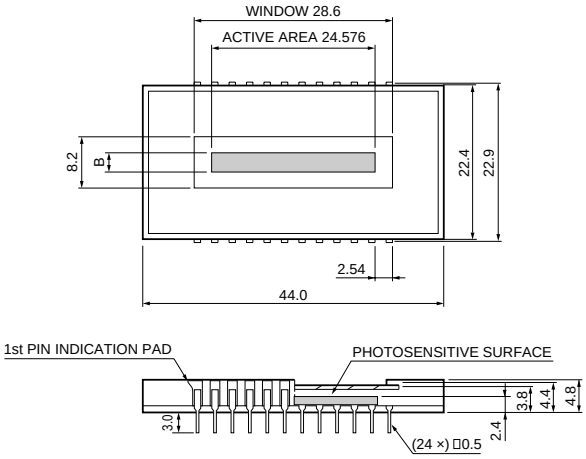
S7033-1007



S7033-1007: B=2.928

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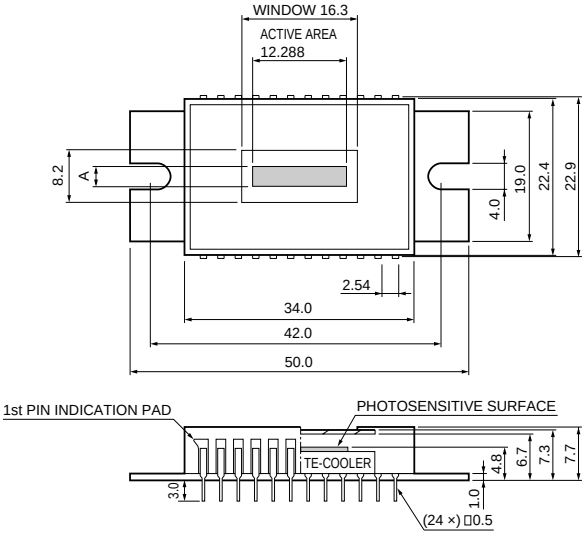
S7034-0907S



S7034-0907S: A=2.928

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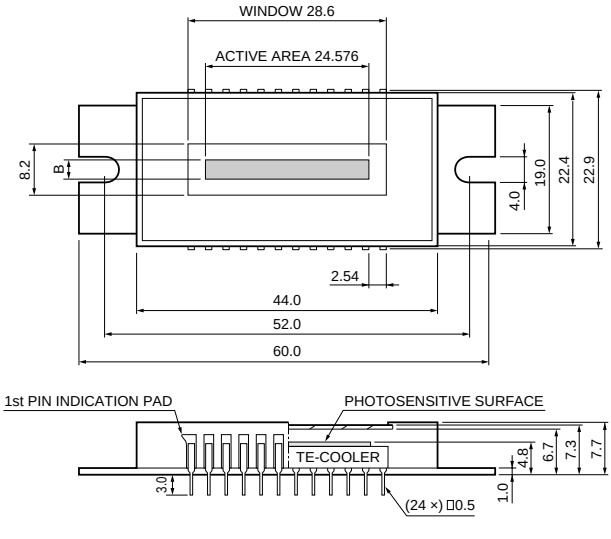
S7034-1007S



S7034-1007S: B=2.928

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■ Pin connections

Pin No.	S7033 series		S7034 series		Remark (standard operation)
	Symbol	Function	Symbol	Function	
1	RD	Reset drain	RD	Reset drain	+12 V
2	OS	Output transistor source	OS	Output transistor source	RL=10 k to 100 kΩ
3	OD	Output transistor drain	OD	Output transistor drain	+20 V
4	OG	Output gate	OG	Output gate	+3 V
5	SG	Summing gate	SG	Summing gate	Same pulse as P2H
6	-		-		
7	-		-		
8	P2H	CCD horizontal register clock-2	P2H	CCD horizontal register clock-2	
9	P1H	CCD horizontal register clock-1	P1H	CCD horizontal register clock-1	
10	IG2H	Test point (horizontal input gate-2)	IG2H	Test point (horizontal input gate-2)	0 V
11	IG1H	Test point (horizontal input gate-1)	IG1H	Test point (horizontal input gate-1)	0 V
12	ISH	Test point (horizontal input source)	ISH	Test point (horizontal input source)	Connect to RD
13	TG *18	Transfer gate	TG *15	Transfer gate	Same pulse as P2V
14	P2V	CCD vertical register clock-2	P2V	CCD vertical register clock-2	
15	P1V	CCD vertical register clock-1	P1V	CCD vertical register clock-1	
16	-		Th1	Thermistor	
17	-		Th2	Thermistor	
18	-		P-	TE-cooler-	
19	-		P+	TE-cooler+	
20	SS	Substrate (GND)	SS	Substrate (GND)	GND
21	ISV	Test point (vertical input source)	ISV	Test point (vertical input source)	Connect to RD
22	IG2V	Test point (vertical input gate-2)	IG2V	Test point (vertical input gate-2)	0 V
23	IG1V	Test point (vertical input gate-1)	IG1V	Test point (vertical input gate-1)	0 V
24	RG	Reset gate	RG	Reset gate	

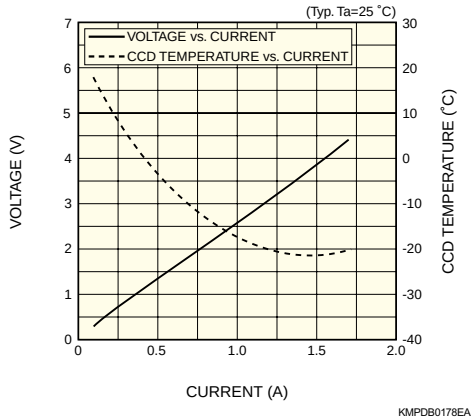
*18: Isolation gate between vertical register and horizontal register.
In standard operation, TG should be applied the same pulse as P2V.

■ Specifications of built-in TE-cooler (Typ.)

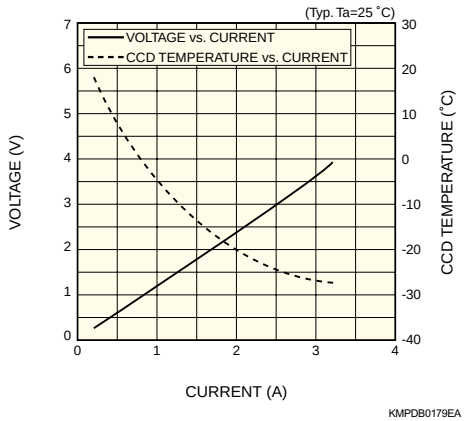
Parameter	Symbol	Condition	S7034-0907S	S7034-1007S	Unit
Internal resistance	Rint	Ta=25 °C	2.5	1.2	Ω
Maximum current *19	Imax	Tc *20=Th *21=25 °C	1.5	3.0	A
Maximum voltage	Vmax	Tc *20=Th *21=25 °C	3.8	3.6	V
Maximum heat absorption *22	Qmax		3.4	5.1	W
Maximum temperature of heat radiating side	-		70	70	°C

*19: Maximum current Imax:
If the current greater than this value flows into the thermoelectric cooler, the heat absorption begins to decrease due to the Joule heat. It should be noted that this value is not the damage threshold value. To protect the thermoelectric cooler and maintain stable operation, the supply current should be less than 60 % of this maximum current.
*20: Temperature of the cooling side of thermoelectric cooler
*21: Temperature of the heat radiating side of thermoelectric cooler
*22: Maximum heat absorption Qmax.
This is a theoretical heat absorption level that offsets the temperature difference in the thermoelectric cooler when the maximum current is supplied to the unit.

S7034-0907S



S7034-1007S

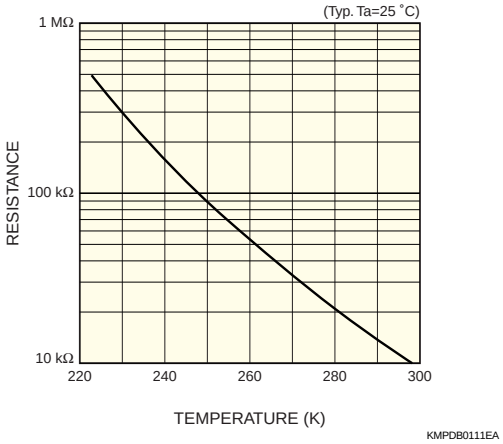


■ Specifications of built-in temperature sensor

A chip thermistor is built in the same package with a CCD chip, and the CCD chip temperature can be monitored with it. A relation between the thermistor resistance and absolute temperature is expressed by the following equation.

R1 = R2 × expB (1 / T1 - 1 / T2)
where R1 is the resistance at absolute temperature T1 (K)
R2 is the resistance at absolute temperature T2 (K)
B is so-called the B constant (K)

The characteristics of the thermistor used are as follows.
R (298K) = 10 kΩ
B (298K / 323K) = 3450 K



■ Precaution for use (Electrostatic countermeasures)

- Handle these sensors with bare hands or wearing cotton gloves. In addition, wear anti-static clothing or use a wrist band with an earth ring, in order to prevent electrostatic damage due to electrical charges from friction.
- Avoid directly placing these sensors on a work-desk or work-bench that may carry an electrostatic charge.
- Provide ground lines or ground connection with the work-floor, work-desk and work-bench to allow static electricity to discharge.
- Ground the tools used to handle these sensors, such as tweezers and soldering irons.

It is not always necessary to provide all the electrostatic measures stated above. Implement these measures according to the amount of damage that occurs.

■ Element cooling/heating temperature incline rate

Element cooling/heating temperature incline rate should be set at less than 5 K/min.

Multichannel detector head C7043/C7044

Features

- C7043: for S7033 series
  C7044: for S7034 series
- Area scanning or full line-binnng operation
- Readout frequency: 250 kHz
- Readout noise: 60 e⁻rms
- ΔT=50 ˚C (ΔT changes by cooling method.)

Input	Symbol	Value
Supply voltage	V_{D1}	+5 Vdc, 200 mA
	V_{A1+}	+15 Vdc, +100 mA
	V_{A1-}	-15 Vdc, -100 mA
	V_{A2}	+24 Vdc, 30 mA
	V_{D2}	+5 Vdc, 30 mA (C7044)
	Vp	+5 Vdc, 2.5 A (C7044)
	V_F	+12 Vdc, 100 mA (C7044)
Master start	ϕms	HCMOS logic compatible
Master clock	ϕmc	HCMOS logic compatible, 1 MHz

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